

## Special Issue

# New Trends and Future Challenges in Computational Microwave Imaging

### Message from the Guest Editors

This Special Issue is aimed at highlighting the challenges, current trends, and most recent advances in computational microwave imaging as applied to several non-invasive *EM* problems. Keywords:

- Computational microwave imaging
- Inverse scattering
- Biomedical imaging
- Subsurface imaging
- Through-the-wall imaging
- Non-destructive testing/evaluation
- Structural health monitoring

Please click [here](#) to find information!  
Welcome to contribute!

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### Guest Editors

Prof. Dr. Maokun Li

Dr. Marco Salucci

Dr. Alessandro Polo

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### Deadline for manuscript submissions

closed (31 March 2021)



## Electronics

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## About the Journal

### Message from the Editor-in-Chief

*Electronics* is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

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### Editor-in-Chief

Prof. Dr. Flavio Canavero

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